

<div> <div>Notice of References Cited</div> </div>	<div>Application/Control No.</div> <div>10/540,952</div>	<div>Applicant(s)/Patent Under Reexamination</div> <div>TAKAHASHI ET AL.</div>	
	<div>Examiner</div> <div>Tiffany A. Fetzner</div>	<div>Art Unit</div> <div>2831</div>	<div>Page 1 of 1</div>

U.S. PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0167317 A1	11-2002	Shenoy et al.	324/307
*	B	US-7,119,540	10-2006	Shenoy et al.	324/309
*	C	US-5,412,321	05-1995	Kohno et al.	324/309
*	D	US-5,187,439	02-1993	Jensen et al.	324/309
*	E	US-7,064,547	06-2006	King et al.	324/309
*	F	US-6,307,368	10-2001	Vasanawala et al.	324/309
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.